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SUBSTITUTE FORM PTO-1449 (MODIFIED) U.S. DEPARTMENT OF COMMER PATENT AND TRADEMARK OFF											ATTY. DOCKET NO. IBM/174DV1 SERIAL NO. PILED HER			SERIAL NO. 10/662,
	INFORMATION DISCLOSURE STATEMENT BY APPLICANT										APPLICANT John Michael Borkenhagen et al.			
(Use several sheets if necessary) (37 CFR 1.98(b))											FILING DATE September 12, 2003			GROUP 2824
							-		U.S. F	PATENT DOCUMENTS				
EXAMINER INITIAL		PATENT NUMBER						₹	ISSUE DATE	PATENTEE		CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
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70	A.E													
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Bu	A.R	"Double Data Rate (DDR) SDRAM Specification", <u>JEDEC Standard</u> , JESD79, JEDEC Solid State Technology Association 2000, Arlington, VA, (6/2000).												
Bu	AS									,558, entitled "Programm" (ROC920000157US1).	nable Co	mpensated (Delay for DDR S	DRAM Interface,"
	A.T					<u>-</u>						· · · · · · ·		
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